

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/584,839	CHO ET AL.	
	Examiner	Art Unit	
	/Yonel Beaulieu/	3661	

Search Notes



Application/Control No.

10/584,839

Examiner

/Yonel Beaulieu/

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Reexamination**

CHO ET AL.

Art Unit

3661

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Searched above		7/17/2010	YB

SEARCH NOTES (INCLUDING SEARCH STRATEGY)